

<b>Notice of References Cited</b>	Application/Control No. 10/771,885		Applicant(s)/Patent Under Reexamination TYAN ET AL.	
	Examiner Natalie K. Walford		Art Unit 2879	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0107314	06-2003	Urabe et al.	313/506
*	B	US-2004/0007664	01-2004	Mitchell, Donald K.	250/237.00G
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1154676 A1	11-2001	European Patent	YAMADA et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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